## Notice of References Cited Application/Control No. 10/754,174 Examiner Nikita R Veniaminov Applicant(s)/Patent Under Reexamination LAU ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,432,039 B1	08-2002	Wardle, John L.	600/37
	В	US-6,723,041 B2	04-2004	Lau et al.	600/37
	O	US-5,889,910 A	03-1999	lgl et al.	385/100
	D	US-4,217,706	08-1980	Vartanian, Vincent A.	36/110
	E	US-3,855,715	12-1974	Johnson, William Peter	36/50.1
	F	US-2004/0143156 A1	07-2004	Lau et al.	600/037
	G	US-			
	Η	US-			
	-	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	R					
	S					
	T					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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	w					
	х					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.